

N-Channel Enhancement Mode MOSFET

Features

20V/5A,

 $R_{DS(ON)} = 35 m\Omega \text{ (Typ.)} @ V_{GS} = 10 V$

 $R_{DS(ON)} = 45 m\Omega$ (Typ.) @ $V_{GS} = 4.5 V$

 $R_{DS(ON)} = 110 m\Omega \text{ (Typ.)} @ V_{GS} = 2.5 V$

- · Super High Dense Cell Design
- · Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

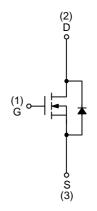
Applications

- Switching Regulators
- · Switching Converters

Pin Description

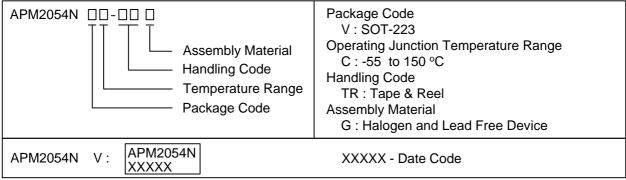


Top View of SOT-223



N-Channel MOSFET

Ordering and Marking Information



Note: ANPEC lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. ANPEC lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020C for MSL classification at lead-free peak reflow temperature. ANPEC defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.



Absolute Maximum Ratings ($T_A = 25$ °C unless otherwise noted)

Symbol	Parameter	Rating	Unit	
V_{DSS}	Drain-Source Voltage		20	V
V_{GSS}	Gate-Source Voltage		±16	V
I _D *	Continuous Drain Current	V 40V	5	Α
I _{DM} *	Pulsed Drain Current	V _{GS} =10V	20	A
l _S *	Diode Continuous Forward Current	3	А	
T_J	Maximum Junction Temperature	150	°C	
T _{STG}	Storage Temperature Range	-55 to 150	C	
D *	b* Power Dissipation for Single Operation	T _A =25°C	1.47	W
r _D "		T _A =100°C	0.58	VV
$R_{\theta JA}^*$	Thermal Resistance-Junction to Ambient	85	°C/W	

Note : *Surface Mounted on $1in^2$ pad area, $t \le 10sec$.

Electrical Characteristics $(T_A = 25^{\circ}C \text{ unless otherwise noted})$

Cymbal	Doromotor	Took Conditions	APM2054NV			Unit
Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Jill
STATIC C	HARACTERISTICS					
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V, I_{DS} =250 μ A	20	-	-	V
	Zero Gate Voltage Drain Current	V _{DS} =16V, V _{GS} =0V	-	-	1	
I _{DSS}		T _J =85°C	-	-	30	μΑ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{DS}=250\mu A$	0.6	0.9	1.5	V
I _{GSS}	Gate Leakage Current	$V_{GS}=\pm 16V, V_{DS}=0V$	-	-	±100	nA
		V_{GS} =10V, I_{DS} =5A	ı	35	40	
R _{DS(ON)} a	Drain-Source On-state Resistance	V _{GS} =4.5V, I _{DS} =3.5A	ı	45	54	mΩ
		V _{GS} =2.5V, I _{DS} =2.5A	-	110	130	
V_{SD}^{a}	Diode Forward Voltage	I_{SD} =3A, V_{GS} =0V	-	0.85	1.3	V
GATE CHARGE CHARACTERISTICS ^b						
Q_g	Total Gate Charge		-	11	13	
Q_gs	Gate-Source Charge	V _{DS} =10V, V _{GS} =4.5V, I _{DS} =6A	-	3.8	-	nC
Q_{gd}	Gate-Drain Charge	7.03	-	5.2	-	

APM2054NV



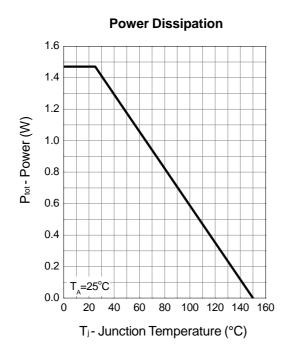
Electrical Characteristics (Cont.) ($T_A = 25^{\circ}C$ unless otherwise noted)

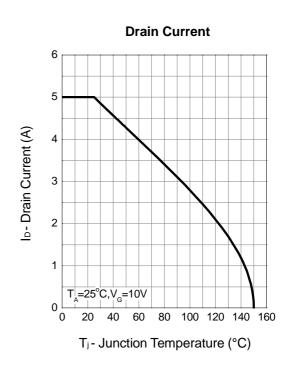
Symbol	Parameter	Test Conditions	APM2054NV			I Imit
Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Unit
DYNAMIC	CHARACTERISTICS b		,			
t _{d(ON)}	Turn-On Delay Time		-	7	10	
Tr	Turn-On Rise Time	V_{DD} =10V, R_L =10 Ω , I_{DS} =1A, V_{GEN} =4.5V,	-	15	25	ns
t _{d(OFF)}	Turn-Off Delay Time	$R_{G}=6\Omega$	-	19	26	115
T_f	Turn-Off Fall Time		-	6	7	
R_{G}	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	2.5	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V,	-	450	-	
C _{oss}	Output Capacitance	V _{DS} =20V,	-	100	-	pF
C _{rss}	Reverse Transfer Capacitance	Frequency=1.0MHz	-	60	-	

Note a : Pulse test ; pulse width≤300µs, duty cycle≤2%. Note b : Guaranteed by design, not subject to production testing.

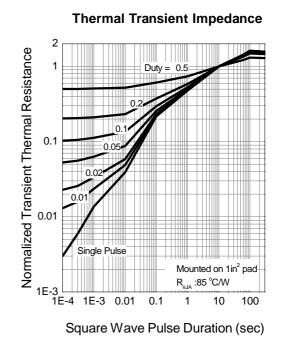


Typical Operating Characteristics



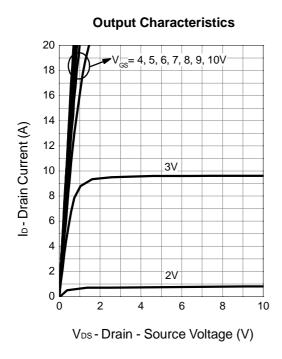


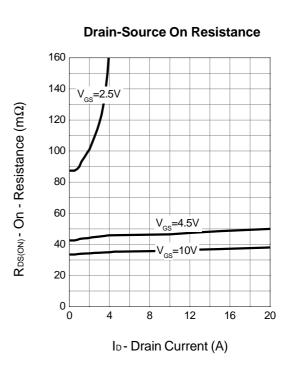
V_{DS} - Drain - Source Voltage (V)

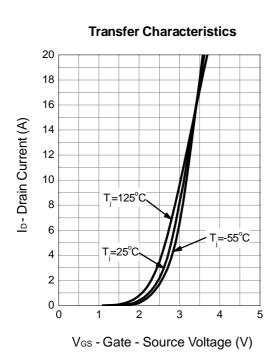


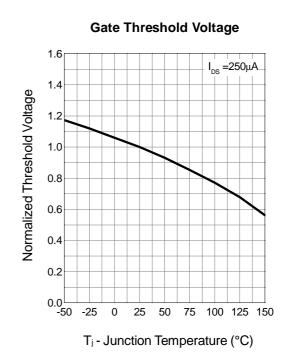


Typical Operating Characteristics (Cont.)





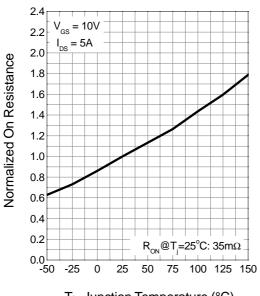






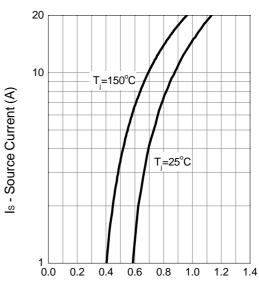
Typical Operating Characteristics (Cont.)

Drain-Source On Resistance



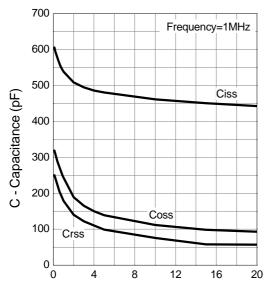
T_j- Junction Temperature (°C)

Source-Drain Diode Forward



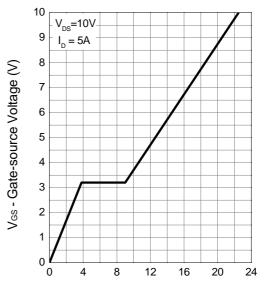
Vsp - Source - Drain Voltage (V)

Capacitance



V_{DS} - Drain - Source Voltage (V)

Gate Charge

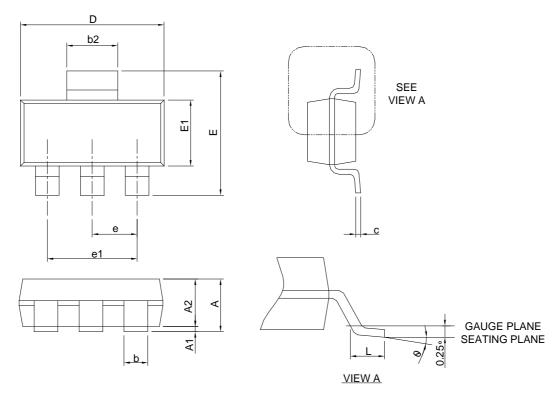


Q_G - Gate Charge (nC)



Package Information

SOT-223



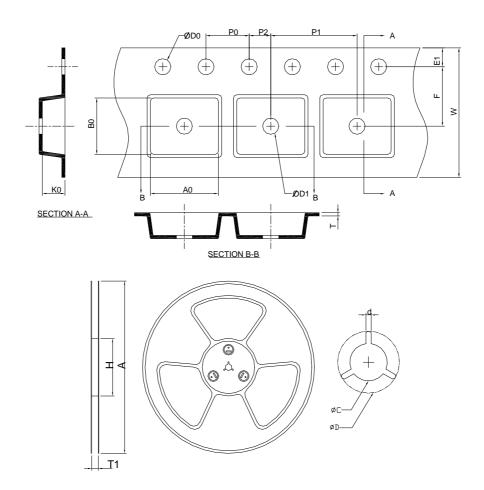
Ş		SOT-223				
SYMBOL	MILLIM	ETERS	INC	HES		
P	MIN.	MAX.	MIN.	MAX.		
Α		1.80		0.071		
A1	0.02	0.10	0.001	0.004		
A2	1.50	1.70	0.059	0.067		
b	0.66	0.84	0.026	0.033		
b2	2.90	3.10	0.114	0.122		
С	0.23	0.33	0.009	0.013		
D	6.30	6.70	0.248	0.264		
E	6.70	7.30	0.264	0.287		
E1	3.30	3.70	0.130	0.146		
е	2.30 BSC		0.09	1 BSC		
e1	4.60 BSC		0.18	1 BSC		
L	0.75		0.030			
θ	0°	10°	0°	10°		

Note: 1. Follow from JEDEC TO-261 AA.

Dimension D and E1 are determined at the outermost extremes of the plastic exclusive of mold flash, tie bar burrs, gate burrs, and interlead flash, but including any mismatch between the top and bottom of the plastic body.



Carrier Tape & Reel Dimensions



Application	Α	Н	T1	С	d	D	W	E1	F
	320.0	50 MIN.	12.4+2.00 -0.00	13.0+0.50 -0.20	1.5 MIN.	20.2 MIN.	12.00 ± 0.30	1.75 ±0.10	5.50 ±0.05
SOT-223	P0	P1	P2	D0	D1	Т	A0	В0	K0
	4.00 ± 0.10	8.00 ± 0.10	2.00 ±0.50	1.5+0.10 -0.00	1.5 MIN.	0.6+0.00 -0.40	6.90 ± 0.20	7.50 ±0.20	2.10 ±0.20

(mm)

Devices Per Unit

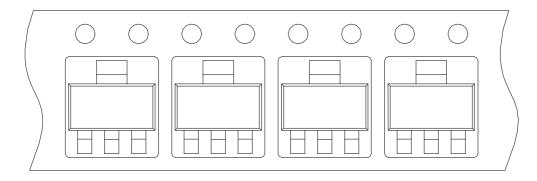
Package Type	Unit	Quantity
SOT-223	Tape & Reel	2500



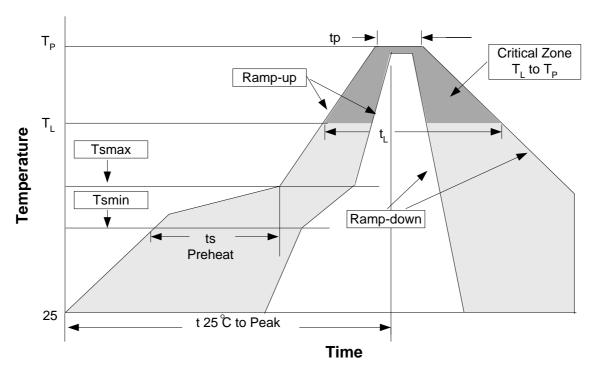
Taping Direction Information

SOT-223





Reflow Condition (IR/Convection or VPR Reflow)



Reliability Test Program

Test item	Method	Description
SOLDERABILITY	MIL-STD-883D-2003	245°C, 5 sec
HOLT	MIL-STD-883D-1005.7	1000 Hrs Bias @125°C
PCT	JESD-22-B, A102	168 Hrs, 100%RH, 121°C
TST	MIL-STD-883D-1011.9	-65°C~150°C, 200 Cycles



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate $(T_L \text{ to } T_P)$	3°C/second max.	3°C/second max.
Preheat - Temperature Min (Tsmin) - Temperature Max (Tsmax) - Time (min to max) (ts)	100°C 150°C 60-120 seconds	150°C 200°C 60-180 seconds
Time maintained above: - Temperature (T _L) - Time (t _L)	183°C 60-150 seconds	217°C 60-150 seconds
Peak/Classification Temperature (Tp)	See table 1	See table 2
Time within 5°C of actual Peak Temperature (tp)	10-30 seconds	20-40 seconds
Ramp-down Rate	6°C/second max.	6°C/second max.
Time 25°C to Peak Temperature	6 minutes max.	8 minutes max.

Note: All temperatures refer to topside of the package. Measured on the body surface.

Table 1. SnPb Eutectic Process – Package Peak Reflow Temperatures

Package Thickness	Volume mm ³ <350	Volume mm³ ³350
<2.5 mm	240 +0/-5°C	225 +0/-5°C
≥2.5 mm	225 +0/-5°C	225 +0/-5°C

Table 2. Pb-free Process – Package Classification Reflow Temperatures

Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
<1.6 mm	260 +0°C*	260 +0°C*	260 +0°C*
1.6 mm – 2.5 mm	260 +0°C*	250 +0°C*	245 +0°C*
≥2.5 mm	250 +0°C*	245 +0°C*	245 +0°C*

^{*}Tolerance: The device manufacturer/supplier **shall** assure process compatibility up to and including the stated classification temperature (this means Peak reflow temperature +0°C. For example 260°C+0°C) at the rated MSL level.

Customer Service

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